

MAC8SD, MAC8SM, MAC8SN

Preferred Device

Sensitive Gate Triacs

Silicon Bidirectional Thyristors

Designed for industrial and consumer applications for full wave control of ac loads such as appliance controls, heater controls, motor controls, and other power switching applications.

- Sensitive Gate Allows Triggering by Microcontrollers and other Logic Circuits
- Uniform Gate Trigger Currents in Three Quadrants; Q1, Q2, and Q3
- High Immunity to dv/dt — 25 V/ μs Minimum at 110°C
- High Commutating di/dt — 8.0 A/ms Minimum at 110°C
- Minimum and Maximum Values of I_{GT} , V_{GT} and I_H Specified for Ease of Design
- On-State Current Rating of 8 Amperes RMS at 70°C
- High Surge Current Capability — 70 Amperes
- Blocking Voltage to 800 Volts
- Rugged, Economical TO220AB Package
- Device Marking: Logo, Device Type, e.g., MAC8SM, Date Code

MAXIMUM RATINGS ($T_J = 25^\circ C$ unless otherwise noted)

Rating	Symbol	Value	Unit
Peak Repetitive Off-State Voltage ⁽¹⁾ ($T_J = -40$ to $110^\circ C$, Sine Wave, 50 to 60 Hz, Gate Open)	V_{DRM} , V_{RRM}	400 600 800	Volts
On-State RMS Current (Full Cycle Sine Wave, 60 Hz, $T_C = 70^\circ C$)	$I_T(RMS)$	8.0	Amps
Peak Non-Repetitive Surge Current (One Full Cycle Sine Wave, 60 Hz, $T_J = 110^\circ C$)	I_{TSM}	70	Amps
Circuit Fusing Consideration ($t = 8.3$ ms)	I^2t	20	A ² sec
Peak Gate Power (Pulse Width ≤ 1.0 μs , $T_C = 70^\circ C$)	P_{GM}	16	Watts
Average Gate Power ($t = 8.3$ ms, $T_C = 70^\circ C$)	$P_{G(AV)}$	0.35	Watt
Operating Junction Temperature Range	T_J	-40 to +110	$^\circ C$
Storage Temperature Range	T_{stg}	-40 to +150	$^\circ C$

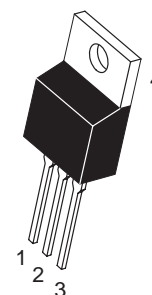
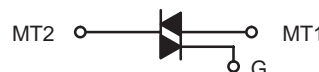
(1) V_{DRM} and V_{RRM} for all types can be applied on a continuous basis. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.



ON Semiconductor

<http://onsemi.com>

TRIACS
8 AMPERES RMS
400 thru 800 VOLTS



TO-220AB
CASE 221A
STYLE 4

PIN ASSIGNMENT

1	Main Terminal 1
2	Main Terminal 2
3	Gate
4	Main Terminal 2

ORDERING INFORMATION

Device	Package	Shipping
MAC8SD	TO220AB	50 Units/Rail
MAC8SM	TO220AB	50 Units/Rail
MAC8SN	TO220AB	50 Units/Rail

Preferred devices are recommended choices for future use and best overall value.

MAC8SD, MAC8SM, MAC8SN

THERMAL CHARACTERISTICS

Characteristic	Symbol	Value	Unit
Thermal Resistance — Junction to Case — Junction to Ambient	$R_{\theta JC}$ $R_{\theta JA}$	2.2 62.5	$^{\circ}C/W$
Maximum Lead Temperature for Soldering Purposes 1/8" from Case for 10 Seconds	T_L	260	$^{\circ}C$

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted; Electricals apply in both directions)

Characteristic	Symbol	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

Peak Repetitive Blocking Current ($V_D = \text{Rated } V_{DRM}, V_{RRM}$; Gate Open)	I_{DRM}, I_{RRM}	— —	— —	0.01 2.0	mA
$T_J = 25^{\circ}C$ $T_J = 110^{\circ}C$					

ON CHARACTERISTICS

Peak On-State Voltage* ($I_{TM} = \pm 11A$)	V_{TM}	—	—	1.85	Volts
Gate Trigger Current (Continuous dc) ($V_D = 12V, R_L = 100\Omega$) MT2(+), G(+) MT2(+), G(–) MT2(–), G(–)	I_{GT}	.8 .8 .8	2.0 3.0 3.0	5.0 5.0 5.0	mA
Holding Current ($V_D = 12V$, Gate Open, Initiating Current = $\pm 150mA$)	I_H	1.0	3.0	10	mA
Latching Current ($V_D = 24V, I_G = 5mA$) MT2(+), G(+) MT2(–), G(–) MT2(+), G(–)	I_L	2.0 2.0 2.0	5.0 10 5.0	15 20 15	mA
Gate Trigger Voltage (Continuous dc) ($V_D = 12V, R_L = 100\Omega$) MT2(+), G(+) MT2(+), G(–) MT2(–), G(–)	V_{GT}	0.45 0.45 0.45	0.62 0.60 0.65	1.5 1.5 1.5	Volts

DYNAMIC CHARACTERISTICS

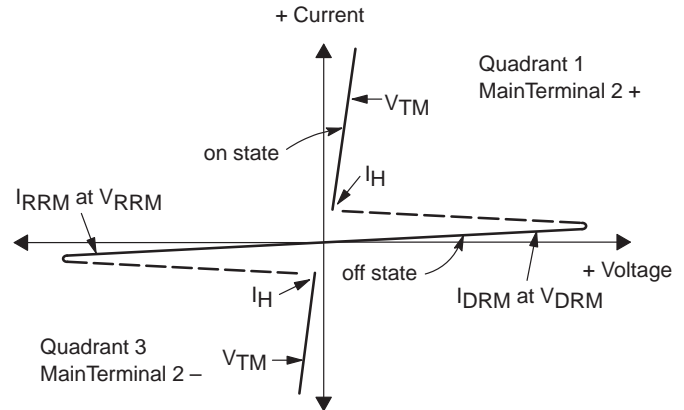
Rate of Change of Commutating Current $V_D = 400V, I_{TM} = 3.5A$, Commutating $dv/dt = 10V/\mu\text{sec}$, Gate Open, $T_J = 110^{\circ}C$, $f = 500Hz$, Snubber: $C_S = 0.01\mu F$, $R_S = 15\Omega$, See Figure 16.)	$di/dt(c)$	8.0	10	—	A/ms
Critical Rate of Rise of Off-State Voltage ($V_D = \text{Rate } V_{DRM}$, Exponential Waveform, $R_{GK} = 510\Omega, T_J = 110^{\circ}C$)	dv/dt	25	75	—	V/ μs

*Indicates Pulse Test: Pulse Width $\leq 2.0ms$, Duty Cycle $\leq 2\%$.

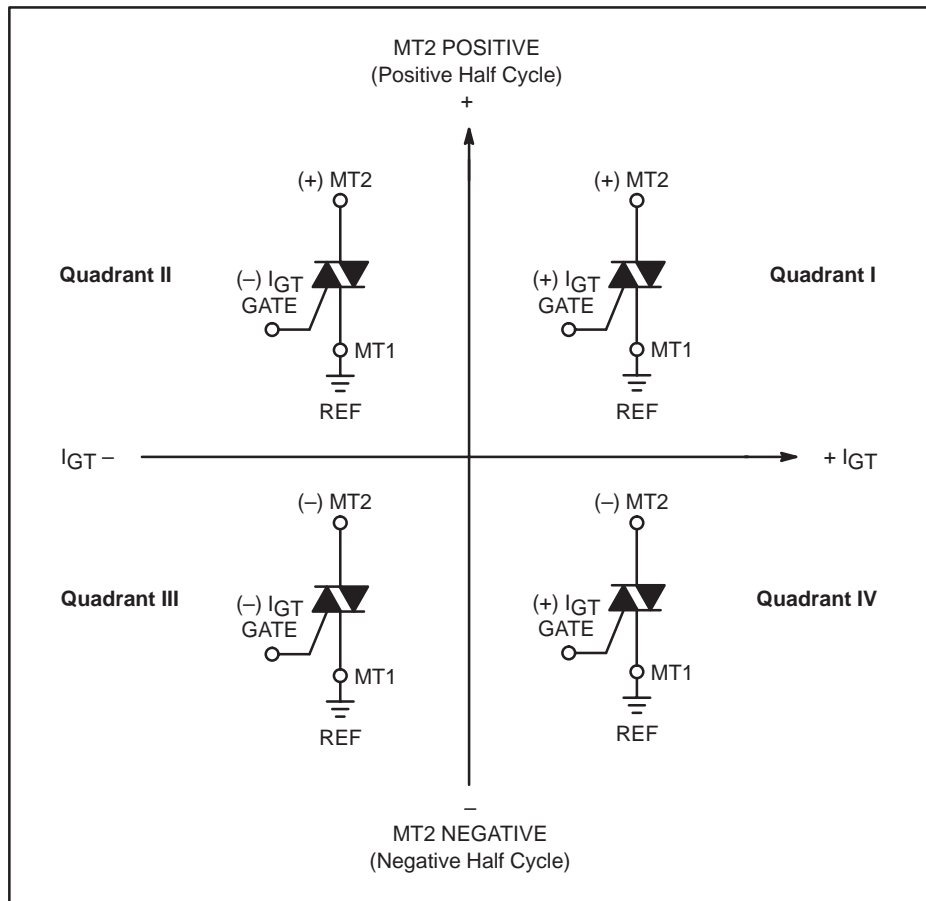
MAC8SD, MAC8SM, MAC8SN

Voltage Current Characteristic of Triacs (Bidirectional Device)

Symbol	Parameter
V_{DRM}	Peak Repetitive Forward Off State Voltage
I_{DRM}	Peak Forward Blocking Current
V_{RRM}	Peak Repetitive Reverse Off State Voltage
I_{RRM}	Peak Reverse Blocking Current
V_{TM}	Maximum On State Voltage
I_H	Holding Current



Quadrant Definitions for a Triac



All polarities are referenced to MT1.
With in-phase signals (using standard AC lines) quadrants I and III are used.

MAC8SD, MAC8SM, MAC8SN

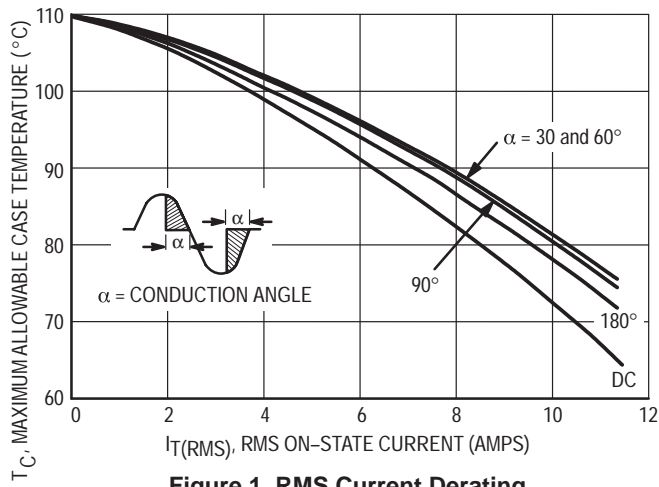


Figure 1. RMS Current Derating

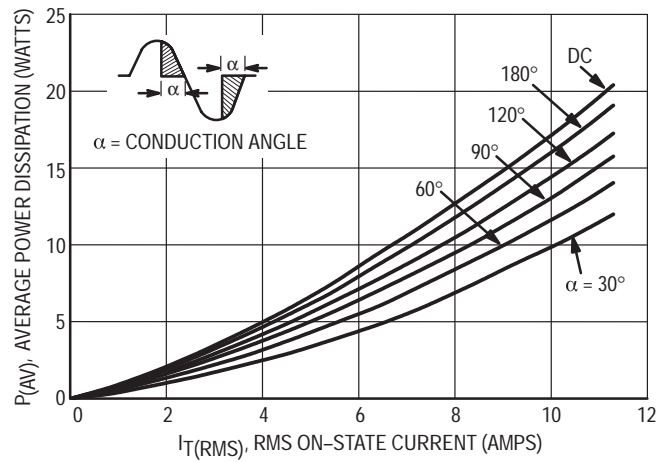


Figure 2. Maximum On-State Power Dissipation

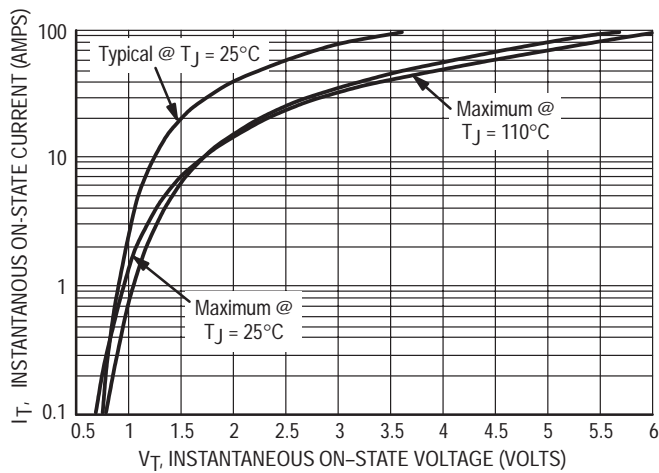


Figure 3. On-State Characteristics

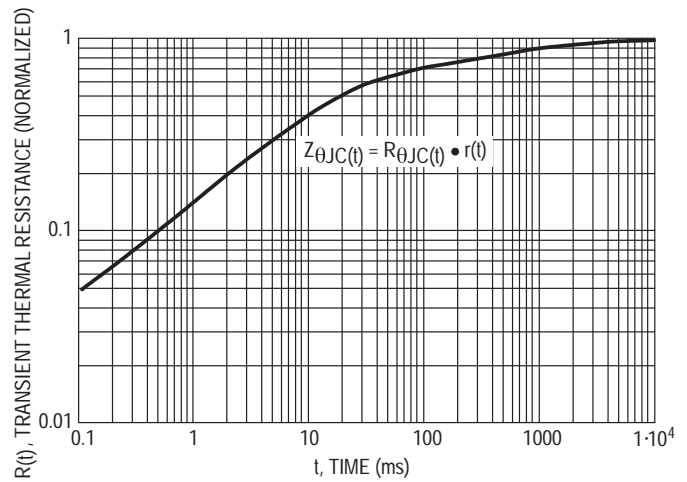


Figure 4. Transient Thermal Response

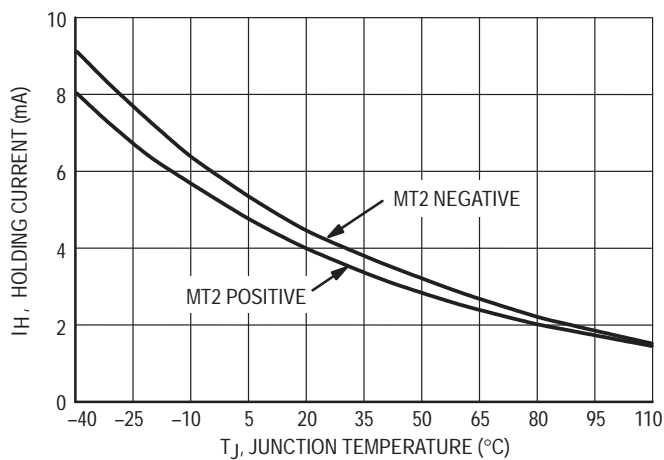


Figure 5. Typical Holding Current Versus Junction Temperature

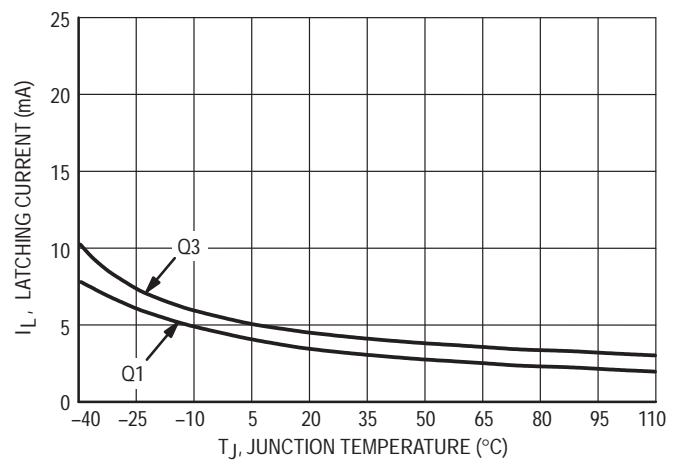


Figure 6. Typical Latching Current Versus Junction Temperature

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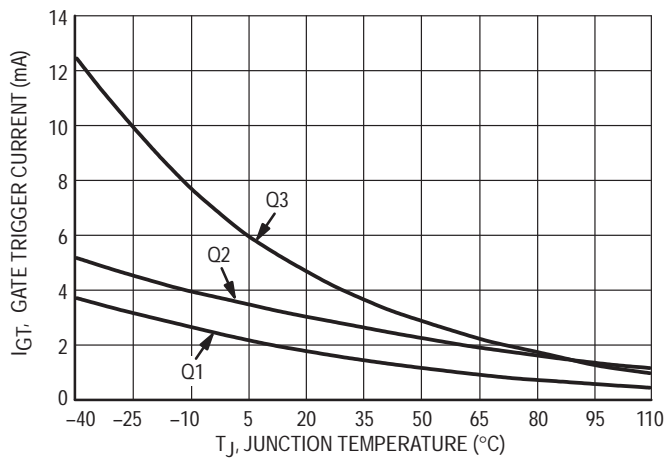


Figure 7. Typical Gate Trigger Current Versus Junction Temperature

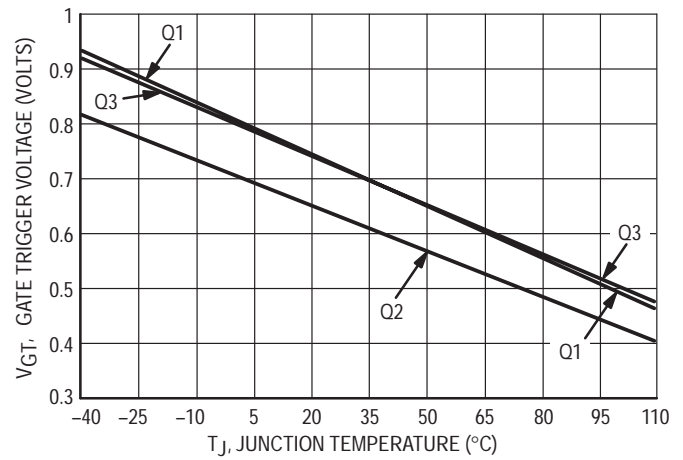


Figure 8. Typical Gate Trigger Voltage Versus Junction Temperature

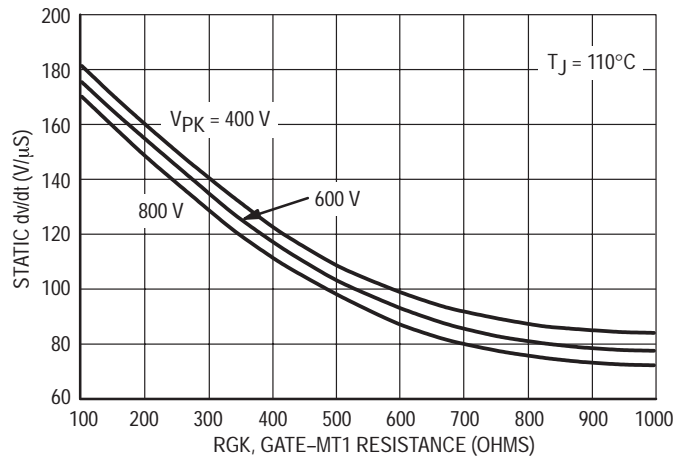


Figure 9. Typical Exponential Static dv/dt Versus Gate-MT1 Resistance, MT2(+)

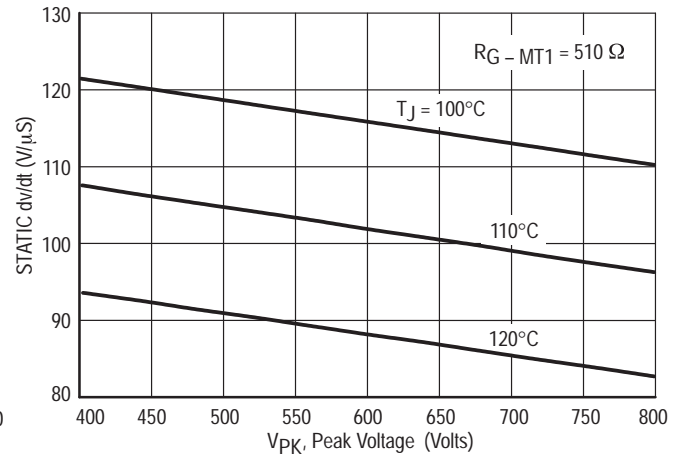


Figure 10. Typical Exponential Static dv/dt Versus Peak Voltage, MT2(+)

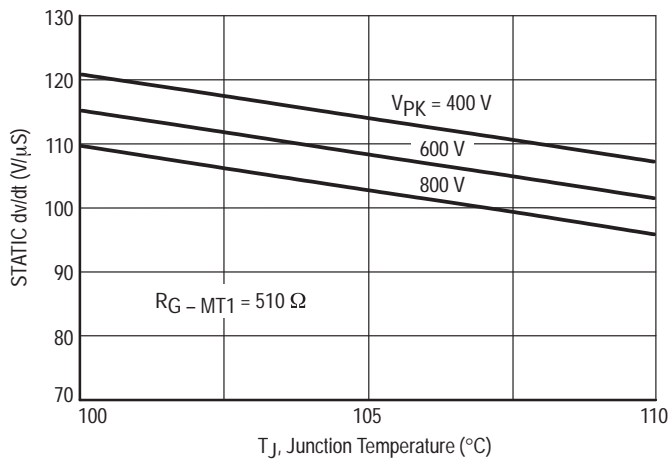


Figure 11. Typical Exponential Static dv/dt Versus Junction Temperature, MT2(+)

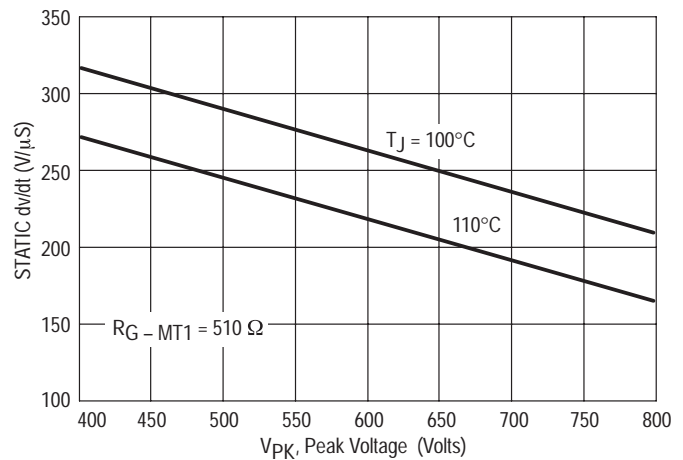


Figure 12. Typical Exponential Static dv/dt Versus Peak Voltage, MT2(-)

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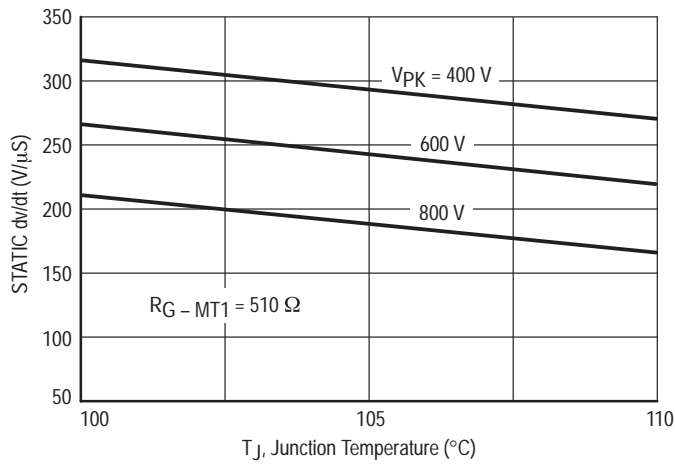


Figure 13. Typical Exponential Static dv/dt Versus Junction Temperature, MT2(-)

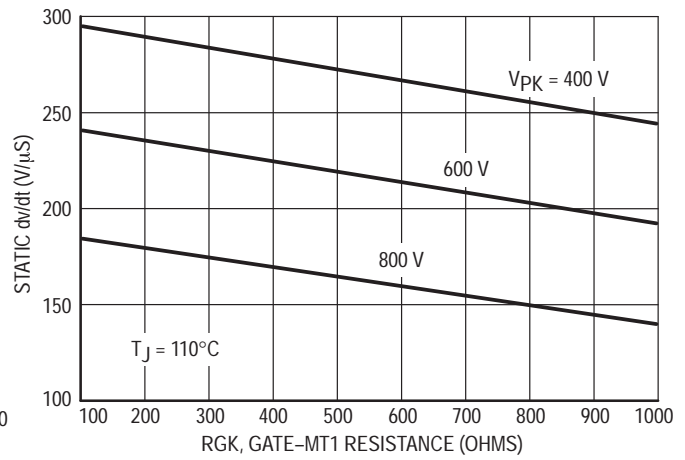


Figure 14. Typical Exponential Static dv/dt Versus Gate-MT1 Resistance, MT2(-)

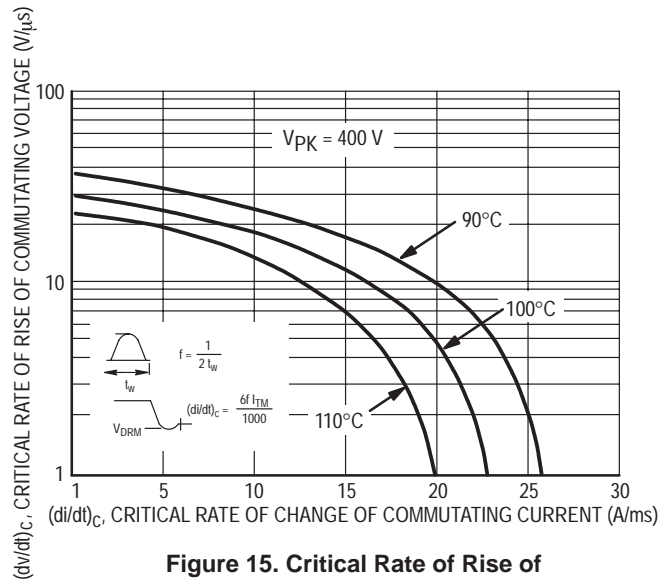


Figure 15. Critical Rate of Rise of Commutating Voltage

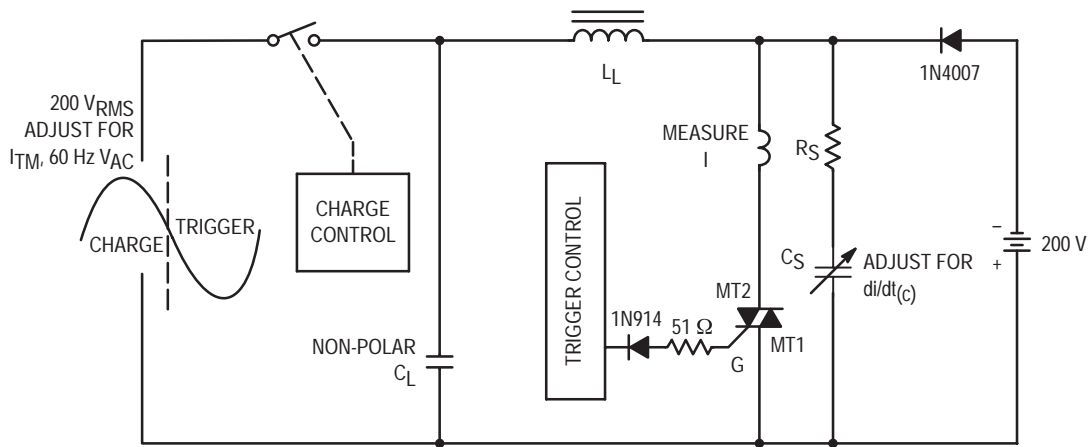
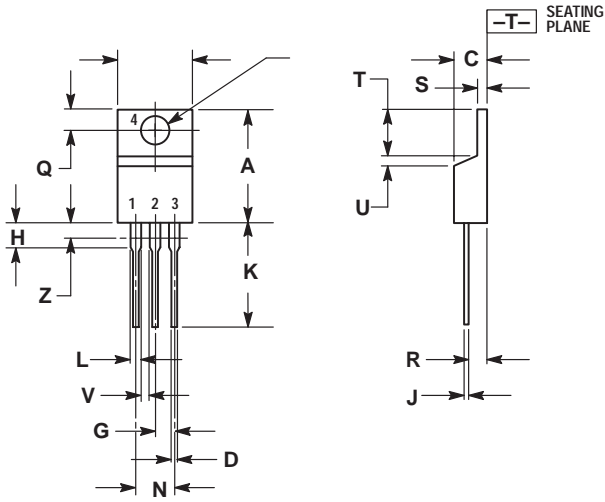


Figure 16. Simplified Test Circuit to Measure the Critical Rate of Rise of Commutating Current (di/dt)_C

MAC8SD, MAC8SM, MAC8SN

PACKAGE DIMENSIONS

TO-220AB CASE 221A-09 ISSUE Z



- NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.
 3. DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.570	0.620	14.48	15.75
B	0.380	0.405	9.66	10.28
C	0.160	0.190	4.07	4.82
D	0.025	0.035	0.64	0.88
F	0.142	0.147	3.61	3.73
G	0.095	0.105	2.42	2.66
H	0.110	0.155	2.80	3.93
J	0.018	0.025	0.46	0.64
K	0.500	0.562	12.70	14.27
L	0.045	0.060	1.15	1.52
N	0.190	0.210	4.83	5.33
Q	0.100	0.120	2.54	3.04
R	0.080	0.110	2.04	2.79
S	0.045	0.055	1.15	1.39
T	0.235	0.255	5.97	6.47
U	0.000	0.050	0.00	1.27
V	0.045	---	1.15	---
Z	---	0.080	---	2.04

- STYLE 4:
- PIN 1. MAIN TERMINAL 1
 - PIN 2. MAIN TERMINAL 2
 - PIN 3. GATE
 - PIN 4. MAIN TERMINAL 2

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